

Application Data Sheet

Application Information

Application Type::	Regular
Subject Matter::	Utility
CD-ROM or CD-R?::	None
Computer Readable Form (CRF)?::	No
Title::	PROBE TESTING METHOD AND APPARATUS FOR DETERMINING ACCEPTABLE/DEFECTIVE END SHAPE OF CONTACT PROBE THROUGH IMAGE ANALYSIS
Attorney Docket Number::	040373-0338
Request for Early Publication?::	No
Request for Non-Publication?::	No
Suggested Drawing Figure::	1
Total Drawing Sheets::	11
Small Entity?::	No
Petition included?::	No
Secrecy Order in Parent Appl.?::	No

Applicant Information

Applicant Authority Type::	Inventor
Primary Citizenship Country::	Japan
Status::	Full Capacity
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Country of Residence::	Japan

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Applicant Authority Type:: Inventor
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Status:: Full Capacity
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Representative Information

Representative Customer Number::	22428	
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Domestic Priority Information

Application::	Continuity Type::	Parent Application::	Parent Filing Date::

Foreign Priority Information

Country::	Application number::	Filing Date::	Priority Claimed::
Japan	2002-240675	08/21/2002	Yes

Assignee Information

Assignee name:: NEC Electronics Corporation